

<b>Notice of References Cited</b>	Application/Control No. 10/700,422	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Hung T Vy	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,346,920 B	02-2002	Sharp et al.	343/773
	B	US-6,198,454 B1	03-2001	Sharp et al.	343/773
	C	US-2003/0214450 A1	11-2003	Lynch et al.	343/772
	D	US-6,714,166 B2	03-2004	Sasaki et al.	343/785
	E	US-6,313,808 B1	11-2001	Yuanzhu, Dou	343/786
	F	US-5,784,033	07-1998	Boldissar, Jr., Frank	343/786
	G	US-5,517,203 A	05-1996	Fiedziuszko, Slawomir J.	343/756
	H	US-5,995,057 A	11-1999	Faith et al.	343/781R
	I	US-5,617,108 A	04-1997	Silinsky et al.	343/786
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.